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Applicants: Naoki TADA et al.

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Enclosed are copies of the publications, which were cited in the International Search Report of International Application No. PCT/JP03/02412. Also enclosed is a copy of Form PTO-1449 and the International Search Report.

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REMARKS

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Entry of this Information Disclosure Statement and an early examination on the merits are respectfully solicited.

Please charge any additional fees to Deposit Account No. 50-0320.

Respectfully submitted,

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Enclosures

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	AL	WO 01/27733	04/19/01	PCT			
	AM	JP 2001-184158	07/06/01	Japan			
	AN	JP 8-161103	06/21/96	Japan			
	AO	JP 2001-92582	04/06/01	Japan			
	AP	JP 8-18632	01/19/96	Japan			
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